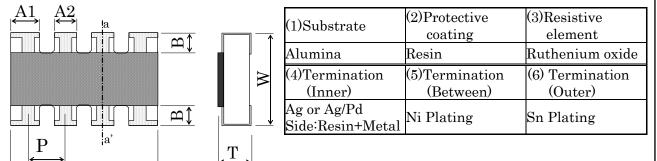
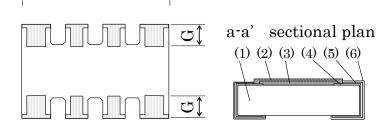


1. Dimension



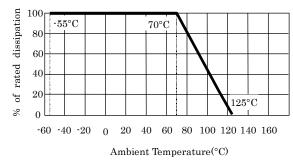


	L	W	T	A1	A2
Dimension(mm)	2.00±0.10	1.00±0.10	0.35 ± 0.10	0.45 ± 0.10	0.35 ± 0.10

	В	P	G
Dimension(mm)	0.20 ± 0.10	(0.50)	0.25 ± 0.10

(): Reference

2. Power derating curve



Category temperature range -55°C to +125°C

Fig. 1

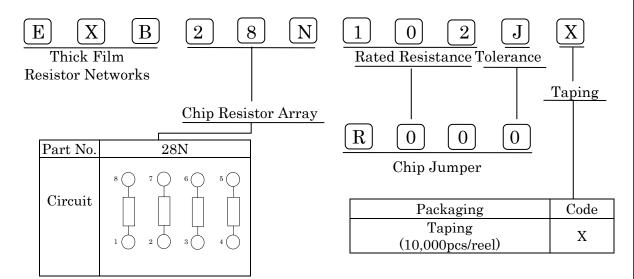
3. Ratings

Item	Rated Value	Explanation			
Rated Dissipation	0.063 W / element	When used at ambient temperature over 70 °C, the rated dissipation should be reduced as shown in Fig.1			
	Chip jumper: Rated current 1 A (Resistance is less than 50 mΩ)				
Rated voltage & Rated Continuous Working Voltage	The rated voltage of each resistor should be calculated equation below, and when the rated voltage exceeds the element voltage, the limiting element voltage should the working voltage.				
(RCWV)	$E = \sqrt{P \times R}$ Limiting element voltage: 50 V E: Rated voltage(V), P: Rated dissipation(W), R: Rated resistance(Ω)				

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Chip Resistor Array PRo	ODUCT SPECIFICATION FOR INFORMATION	151-EXB-28N03DE
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Item	Rate	d Value	Explanation	
D : 4		Sign	Tolerance for resistan	ce
Resistance		J	±5%	
tolerance		0	Chip Jumper	
Range of rated		Tolerance	Resistance range	Series
resistance for		J	$10~\Omega$ to $1.0~\mathrm{M}\Omega$	E-24
manufacture		0	Less than $50~\text{m}\Omega$	-

4. Explanation of part number



5. Appearance & Construction

Item	Specifications	Explanation
Appearance & Construction	that do not far unevenness, fla 2. The electrode dimensions. The unevenness, fla 3. The electrode of resistive elements. 4. Substrate shoul	lement should be covered with protective coating ade easily. The surface of coating should avoid aw, pinhole and discoloration. should be printed uniformly, as shown in the plating should not fade easily, and should avoid aw, pinhole, projection and discoloration. should be connected electrically, mechanically to int. d not have chipping, flaw, flash and crack. Details criteria shall be as described in attached sheet

As far as there shall be not designation especially, the following test and measurement shall be operated under normal temperature(15 °C to 35 °C), normal humidity(25 %RH to 75 %RH), normal atmospheric pressure(86 kPa to 106 kPa).

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Chip Resistor Array PR	RODUCT SPECIFICATION FOR INFORMATION	151-EXB-28N03DE
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6. Performance Specification

T	Specification		m - 4 1
Item	Resistor	Jumper	Test methods
DC resistance	DC resistance value shall be within the specified tolerance	Less than 50 mΩ	Measuring voltage: refer to JIS-C5201-1 At 20 °C, 65 %RH
Temperature coefficient		TCR 00×10 ⁻⁶ / °C 0 mΩ	Natural resistance change per temperature degree centigrade. $TCR = \frac{R_2 \cdot R_1}{R_1 \times (t_2 \cdot t_1)}$ $R_1 : Resistance value at reference temperature(t_1)$ $R_2 : Resistance value at test temperature(t_2)$ $t_2 \cdot t_1 = 100 ^{\circ}\text{C}, \ t_1 = 25 ^{\circ}\text{C}$
Overload	±(2 %+0.1 Ω)	Less than 50 mΩ	Resistors shall be applied 2.5 times the rated voltage for 5 seconds. However, the upper limit of the voltage in the test shall be 100V. In addition, the current applied to the jumper in the test shall be 2A.
Dielectric Withstanding	No evidence of flas mechanical damag insulation breakdo	ge, arcing or	AC 100V between substrate and termination for 1 minute.
Insulation Resistance	Min. 1,000 M Ω		Insulation resistance between substrate and termination shall be measured at DC 100V.

7. Mechanical characteristic

IITem	Specification		Test methods
	Resistor	Jumper	Test methods
Bend strength of	No mechanical dar	nage	Substrate: Glass epoxy(t = 1.0 mm) Span: 90 mm
the face plating	±(1 %+0.05 Ω)	Less than $50 \text{ m}\Omega$	Bending distance: 3 mm (10 seconds)
Solderability	Termination should be covered uniformly with solder.		Resistors shall be dipped in the melted solder bath at 235 °C \pm 5 °C for 2 s \pm 0.5 s. Flux shall be removed from the surface of termination with clean organic solvent.

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Chip Resistor Array PR	ODUCT SPECIFICATION FOR INFORMATION	151-EXB-28N03DE
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Item	Specification		Test methods	
rtem	Resistor	Jumper	Test methods	
Resistance to	±(1 %+0.05 Ω)	Less than	Resistors shall be dipped in the melted solder	
soldering heat	±(1 %+0.05 \(\)2)	$50~\mathrm{m}\Omega$	bath at 270 °C \pm 5 °C for 10s \pm 1s.	
Vibration	±(1 %+0.05 Ω)	Less than $50~\text{m}\Omega$	Resistors shall be subjected to a single vibration having as double amplitude of 1.5 mm for 2 hours in each three mutually perpendicular directions for total 6 hours. The vibration frequency shall be varied uniformly 10 Hz to 55 Hz and return to 10 Hz traversing for 1 minute.	
	Without distinct of appearance	deformation in	in Solvent solution: Isopropyl alcohol (1) Dipping 10 hours ± 1 hour, dry in re	
Solvent resistance	±(0.5 %+0.05 Ω)	Less than 50 mΩ	condition for 30 min ± 10 min. (2) Ultrasonic wave washing: 5 min ± 1 min (0.3 W/cm²,28 kHz) Dry in room condition for 30 min ± 10 min.	

8. Environmental Test

Itom	Specification		Test methods
Item	Resistor	Jumper	Test methods
Low temperature exposure	±(1 %+0.05 Ω)	Less than 50 mΩ	Resistors shall be exposed at -55 °C \pm 3 °C for 1000 hours $^{+48}_{0}$ hours
Endurance at upper category temperature	±(1 %+0.05 Ω)	Less than 50 mΩ	Resistors shall be exposed at +125 °C±3 °C for 1000 hours $^{+48}_{0}$ hours.
Temperature cycling	±(1 %+0.05 Ω)	Less than 50 mΩ	-55 °C ± 3 °C, 30 minutes ↑↓ Nominal temp., 30minutes 25cycles ↑↓ +125 °C ± 3 °C, 30minutes
Humidity (Steady state)	±(1 %+0.05 Ω)	Less than 50 mΩ	Resistors shall be exposed at 60 °C \pm 2 °C and 90 % to 95 % relative humidity in a humidity test chamber for 1000 hours $_0^{+48}$ hours.
Endurance at 70 °C	±(3 %+0.1 Ω)	Less than 50 mΩ	Resistors shall be exposed at 70 °C \pm 2 °C for 1000 hours $_0^{+48}$ hours. During this time, the rated voltage shall be applied intermittently for 1.5 hours ON, 0.5 hour OFF.
Load life in Humidity	±(3 %+0.1 Ω)	Less than 50 mΩ	Resistor shall be exposed at 60 °C \pm 2 °C and 90 % to 95 % relative humidity for 1000 hours $_0^{+48}$ hours. During this time, the rated voltage shall be applied intermittently for 1.5 hours ON, 0.5 hour OFF.

9. Resistance value marking No marking.

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Part No.	
EXB28N	8-5

10. Notice for use



Notice for use

- (1) This specification shows the quality and performance of the product in a unit component. Before adoption, be sure to evaluate and verify the product mounting it in your product.
- (2)We take no responsibility for troubles caused by the product usage that is not specified in this specification.
- (3)In traffic transportation equipment (trains, cars, traffic signal equipment, etc.), medical equipment, aerospace equipment, electric heating appliances, combustion and gas equipment, rotating equipment, disaster and crime preventive equipment, etc. in cases where it is forecast that the failure of this product gives serious damage to human life and others, use fail-safe design and ensure safety by studying the following items to
 - Ensure safety as the system by setting protective circuits and protective equipment.
 - ◆ Ensure safety as the system by setting such redundant circuits as do not cause danger by a single failure.
- (4)When a dogma shall be occurred about safety for this product, be sure to inform us rapidly, operate your technical examination.
- (5) The product is designed to use in general standard applications of general electric equipment (AV products, household electric appliances, office equipment, information and communication equipment, etc.); hence, it do not take the use under the following special environments into consideration.

Accordingly, the use in the following special environments, and such environmental conditions may affect the performance of the product; prior to use, verify the performance, reliability, etc. thoroughly.

- 1) Use in liquids such as water, oil, chemical, and organic solvent.
- 2) Where the product is close to a heating component, or where an inflammable such as a polyvinyl chloride wire is arranged close to the product.
- 3) Where the product is sealed or coated with resin, etc.
- 4) Where water or a water-soluble detergent is used in cleaning free soldering (Pay particular attention to soluble flux.)
- 5) Use in such a place where the product is wetted due to dew condensation.
- 6) Use in places full of corrosive gases such as sea breeze, Cl₂, H₂S, NH₃, SO₂, and NO_X.
- 7) Use under direct sunlight, in outdoor or in dusty atmospheres.
- 8) Use in environment with large static electricity or strong electromagnetic waves.
- (6)If transient load (heavy load on a short time) like pulse is expected to be applied, carry out evaluation and confirmation test with resistors actually mounted on your own board. When the load of more than rated power is applied under the load condition at steady state, it may impair performance and/or reliability of resistor. Never exceed the rated power.

When the product shall be used under special condition, be sure to ask us in advance.

- (7)Halogen type (chlorine type, bromine type, etc.) or other high-activity flux is not recommended as the residue may affect performance or reliability of resistors.
- (8)When soldering with soldering iron, never touch the body of the chip resistor with a tip of the soldering iron. When using a soldering iron with a tip at high temperature, solder for a time as short as possible. (Three seconds or less up to 350 °C)
- (9) Avoid physical shock to the resistor and nipping of the resistor with hard tool (a pair of pliers or tweezers) as it may damage protective firm or the body of resistor and may affect resistor's performance.
- (10)Reflow soldering method shall apply to this product in principle.

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	EXB28N	8-6

11. Storage method

If the product is stored in the following environments and conditions, the performance and solderability may be badly affected. Avoid the storage in the following environments.

- (1) Storage in places full of corrosive gases such as sea breeze, Cl₂, H₂S, NH₃, SO₂, and NO_X.
- (2) Storage in places exposed to direct sunlight.
- (3) Storage in places outside the temperature range of 5 $^{\circ}$ C to 35 $^{\circ}$ C and humidity range of 45 $^{\circ}$ RH to 85 $^{\circ}$ RH.
- (4) Storage over a year after our delivery (This item also applies to the case where the storage method specified in item (1) to (3) has been followed.).

12. Laws and Regulations

- (1) No ODCs or other ozone-depleting substances that are subject to regulation under the Montreal Protocol are used in our manufacturing processes, including in the manufacture of this product.
- (2) This product complies with the RoHS Directive (Restriction of the use of certain Hazardous Substances in electrical and electronic equipment (DIRECTIVE 2002/95/EC)).
- (3) All materials used in this product are existing chemical substances recognized under "lows on examination of chemical substances and regulations of manufacturing and others."
- (4) None of the materials used in this product contain the designated incombustible bromic substances, PBBOs and PBBs.
- (5) Please contact us to obtain a notice as to whether this product has passed inspection under review criteria primarily based on Foreign Exchange and Foreign Trade Control Laws, and appended table in the Export Control Laws.

13. Production Place

Production Country: Japan

Production Plant : Panasonic Electronic Devices Japan Co., Ltd..

Production Country: China

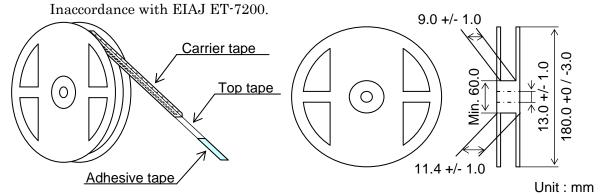
Production Plant : Panasonic Electronic Devices (Tianjin) Co., Ltd.(PEDTJ)

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Chip Resistor Array	PRODUCT SPECIFICATION FOR INFORMATION	151-EXB-28N03DE
Part No.		
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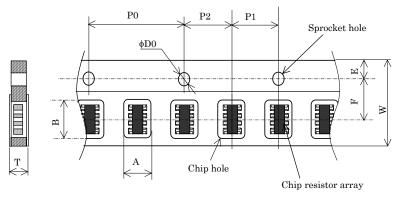
14. Tape and Reel Package

14-1. Physical Dimensions

Structure and reel dimensions shall be as shown in the figure below.



14-2. Carrier Tape Dimensions



	A	В	W	F	E
(mm)	1.20±0.10	2.20±0.10	8.00±0.20	3.50 ± 0.05	1.75±0.10
	P1	P2	P0	Т	φD0

14-3. Specification

14-3-1. Taping

(1) When the test shall be operated with the below conditions, peel strength should be $0.049\mathrm{N}$

to 0.49N, should not have flash and tear after peeling.



(2) Minimum Bending Radius

When carrier tape shall be bent by minimum bending radius (15 mm), no defection of chip and no break of carrier tape. However minimum bending radius shall be tested for 1 times.

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Chip Resistor Array PRODUCT SPECIFICATION FOR IN	NFORMATION 151-EXB-28N03DE
Part No.	
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(3) Resistance to climate

When resistors shall be exposed at $60 \,^{\circ}\text{C} \pm 2 \,^{\circ}\text{C}$, $90 \,^{\circ}\text{RH}$ to $95 \,^{\circ}\text{RH}$ for $120 \,^{\circ}\text{hours}$, no defection of chip and no break off carrier tape.

When the top tape shall be peeled, tape should not have flash and tear.

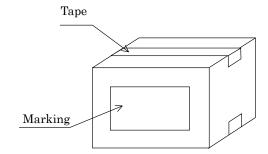
14-3-2. Quantity in Taping: 10,000 pcs. / reel

14-3-3. Tape packaging

- (1) Resistor side shall be facing upward.
- (2) Chip resistor shall not be sticking to top tape and bottom tape.
- (3) Chip resistors shall be easy to take out from carrier tape and chip hole or sprocket hole shall not have flash and break.

14-4. Outer Packaging

Quantity: 20 reels(Max.200,000 pcs.)



- (1) When packaging quantity does not reach max quantity, the remaining empty space shall be buried with buffer material.
- (2) When quantity shall be few, alternative packaging methods may used. No problem must occur during the exportation of the product..

14-5. Marking

At last, production country is displayed in English.

- Side of reel (Marking shall be on one side.)
 - (1)Part name (2)Part number (3)Quantity (4)Lot number (5)Maker name
 - (6)Production country
- Packaging box
 - (1)Customer name (2)Part name (3)Part number (4)Customer part number
 - (5)Quantity (6)Maker name (7) Production country

Subject	Spec. No.
Chip Resistor Array PRODUCT SPECIFICATION FOR INFORMATION	Attached Sheet
APPEARANCE QUALITY CRITERIA	1-1

			.
Item	Defect Criteria	Appearance Criteria	Remark
Resin Chipping		$A \le W/16$ $B \le C/2$	Both side chipping shall be judged defect
Terminal Chipping	Oblique line show chipping	$A \leq C/4$ $B \leq \text{Top terminal width}$ $D \geq 3C/4$	
Pin Hole		One pin hole / $ chip\ resistor \\ \phi \leq 0.2\ mm $	This item is applied to pin holes which react to the resistive materials
Flash	A A A A A A A A A A A A A A A A A A A	A ≤ 100 μm	

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M8340108K3322FCD03 M8340108K4991FGD03 M8340108K6202GGD03 M8340109K2002FCD03 M8340109M4701GCD03 EXB
24N121JX EXB-24N330JX EXB-24N470JX EXB-A10E102J EXB-A10E104J 744C083101JTR EXB-U14360JX EXB-U18240JX EXB
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